

Docket No.: 58647-156

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

: Customer Number: 20277

Takeshi IIJIMA, et al.

Serial No.: Continuation of
Appln. Serial No. 09/894,512

: Group Art Unit: Not yet assigned

Filed: August 04, 2003

: Examiner: Not yet assigned

For: BIOELECTRICAL IMPEDANCE MEASURING APPARATUS

INFORMATION DISCLOSURE STATEMENT

Mail Stop
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached form PTO-1449. It is respectfully requested that the references be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

The references were cited by or submitted to the U.S. Patent and Trademark Office in parent application Serial No. 09/894,512, filed June 29, 2001, which is relied upon for an earlier filing date under 35 USC 120. Thus, copies of these references are not attached. 37 CFR 1.98(d).

Respectfully submitted,

MCDERMOTT, WILL & EMERY

Michael A. Messina

Michael A. Messina

Registration No. 33,424

600 13th Street, N.W.
Washington, DC 20005-3096
(202) 756-8000 MAM:blp
Facsimile: (202) 756-8087
Date: August 4, 2003

INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)			ATTY. DOCKET NO. 58647-156	SERIAL NO. [case_serial_number]	
			APPLICANT Takeshi IIJIMA, et al.		
			FILING DATE August 04, 2003	GROUP [case_group_art]	
U.S. PATENT DOCUMENTS					
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code ₂ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
	US	6,456,873 B1	09/2002	Inoue et al.	
	US	6,370,425 B1	04/2002	Oguma	
	US	6,472,888 B2	10/2002	Oguma et al.	
	US	6,354,996 B1	3/2002	Drinan et al.	
	US	6,360,124 B1	3/2002	Iwabuchi	
	US	6,327,495 B1	12/2001	Iwabuchi et al.	
	US	6,473,641 B1	10/2002	Kodama et al.	
	US	6,256,532 B1	07/2001	Cha	
FOREIGN PATENT DOCUMENTS					
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number & Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document Pages, Columns, Lines Where Relevant Figures Appear	Translation
		JP 2000-135204	5/2000		Yes No
		JP 10-174680	6/1998		
		JP 62169023	7/1987		
		JP 2000166890	6/2000		
		WO 99/20175	4/1999		
		EP 1 031 317	8/2000		
		WO 99/52425	10/1999		
OTHER ART. (Including Author, Title, Date, Pertinent Pages, Etc.)					
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			
		Related Appln. No. 09/510,231, filed February 22, 2000			
EXAMINER			DATE CONSIDERED		

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered.
Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.